

Notice of References Cited		Application/Control No. 10/535,406	Applicant(s)/Patent Under Reexamination LEE ET AL.	
		Examiner RANDAL WILLIS	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0149598	10-2002	Greier et al.	345/589
*	C	US-2002/0180676	12-2002	Lee, Baek-Woon	345/87
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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